Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,291	YASUNAMI ET AL.	
Examiner	Art Unit	_
John S. Chu	1752	

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Class	Subclass	Date	Examiner
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430	325	1	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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INVENTOR SEARCH UPDATED		
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